## Notice of References Cited Application/Control No. 10/621,774 Examiner Lam P. Pham Applicant(s)/Patent Under Reexamination TUTTLE, JOHN R. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,549,125	04-2003	Nigon et al.	340/447
	В	US-5,513,525	05-1996	Schurmann, Josef	73/146.5
	С	US-5,452,608	09-1995	Green, Clifford R.	73/146.8
	۵	US-3,881,170	04-1975	Hosaka et al.	340/448
	Ε	US-6,292,095	09-2001	Fuller et al.	340/442
	F	US-6,255,940	07-2001	Phelan et al.	340/447
	G	US-4,235,184	11-1980	Schiavone, Ben M.	116/34R
	Н	US-			
	ı	US-			
	J	US-		·	
	К	US-			
	L	US-			
	М	US-	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S				·	
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	٧						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.